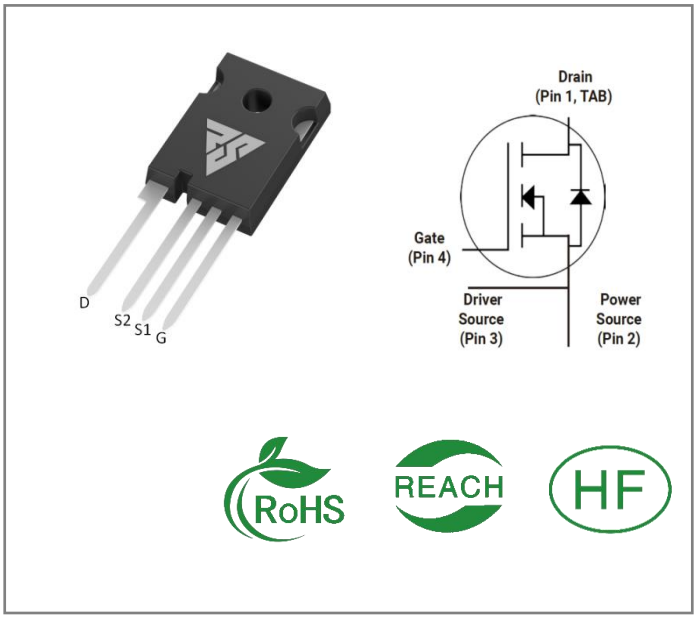
VDS	RDS(on)	ID@25℃
1200V	40mΩ	68A



Applications:

- Solar Inverters
- Switch Mode Power Supplies
- High Voltage DC/DC Converters
- EV Charging
- Motor Drives

Features:

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitances
- Easy to Parallel and Simple to Drive
- Avalanche Ruggedness

Benefits:

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RSM120040Z	TO-247-4	RSM120040Z	Tube	30 PCS

Maximum Ratings (TJ= 25℃ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
VDSmax	Drain - Source Voltage	1200	V	VGS=0V,ID =100μA	
VGSmax	Gate - Source Voltage	-8/+22	V	Absolute maximum values	
VGSop	Gate - Source Voltage	-4/+18	V	Recommended operational values	
ID	Continuous Drain Current	68 49	A	VGS=18V, TC =25℃ VGS=18V, TC =100℃	
ID(pulse)	Pulsed Drain Current	100	A	Pulse width tp limited by TJmax	
PD	Power Dissipation	340	W	TC =25℃, TJ =175℃	
TL	Solder Temperature	260	℃		
TJ, Tstg	Operating Junction and StorageTemperature	-40 to + 175	℃		

Electrical Characteristics (TJ= 25℃ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
V(BR)DSS	Drain-Source Breakdown Voltage	1200			V	VGS=0V,ID =100μA	
VGS(th)	Gate Threshold Voltage	1.9	2.6	4.0	V	VGS= VDS, IDS=9.5mA,TC =25℃	
			1.8		V	VGS= VDS, IDS=9.5mA,TC =175℃	
IDSS	Zero Gate Voltage Drain Current		1	100	μA	VDS= 1200V, VGS=0V	
IGSS	Gate-Source Leakage Current		10	250	nA	VGS=22V, VDS= 0V	
RDS(on)	Drain-Source on-state Resistance		40	53	mΩ	VGS=18V, ID =33.3A, TC =25℃	
			65			VGS=18V, ID =33.3A, TC =175℃	
Ciss	Input Capacitance		2070		pF	VGS=0V, VDS=1000 V, f=1MHz，VAC=25 mV	
Coss	Output Capacitance		112				
Crss	Reverse Transfer Capacitance		11				
EON	Turn-On Switching Energy		1410		μJ	VDS =800V, VGS =-4/18V,ID = 33.3A, RG(ext) = 2.5Ω, L= 200μH	
EOFF	Turn-Off Energy		750				
td(on)	Turn-On Delay Time		17		ns	VDS =800V, VGS =-4/18 V ID = 33.3A, RG(ext) =2. 5 Ω , RL =20Ω	
tr	Rise Time		58				
td(off)	Turn-Off Delay Time		26				
tf	Fall Time		15				
RG(int)	Internal Gate Resistance		4.9		Ω	f=1 MHz, VAC=25mV	
Qgs	Gate to Source Charge		34		nC	VDS=800V, VGS=-4/18V ID =33.3A	
Qgd	Gate to Drain Charge		20		nC		
Qg	Total Gate Charge		121				

Reverse Diode Characteristics (TJ= 25℃ unless otherwise specified)

Symbol	Parameter	Typ.	Max	Unit	Test Conditions	Note
VSD	Diode Forward Voltage	4.5		V	VGS=-4V, ISD = 20 A, TJ = 25℃	
		4.2		V	VGS=-4V, ISD= 20 A, TJ= 175℃	
IS	Continuous Diode Forward Current		51	A	VGS=-4V,TC= 25℃	
trr	Reverse Recovery time	38		ns	ISD= 33.3 A, VR = 800V	
Qrr	Reverse Recovery Charge	109		nC		
Irrm	Peak Reverse Recovery Current	5		A		

Thermal Characteristics (TJ= 25℃ unless otherwise specified)

Symbol	Parameter	Typ.	Unit	Test Conditions	Note
RθJC	Thermal Resistance from Junction to Case	0.44	℃/W		
RθJA	Thermal Resistance From Junction to Ambient	40			

Typical Feature Curve

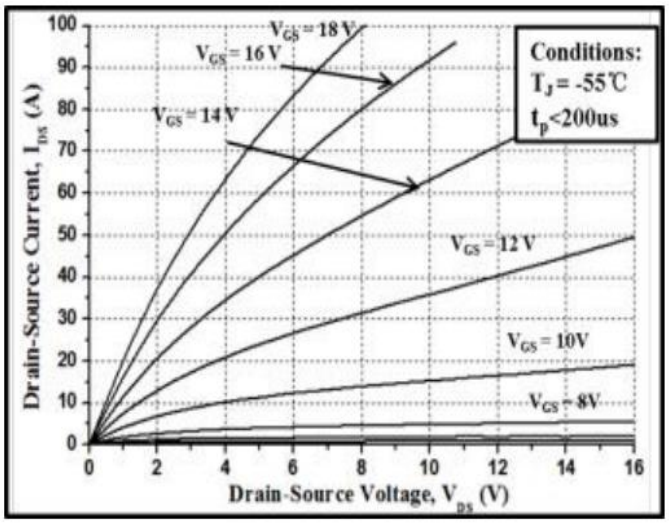


Figure 1. Output Characteristics T_J = -55℃

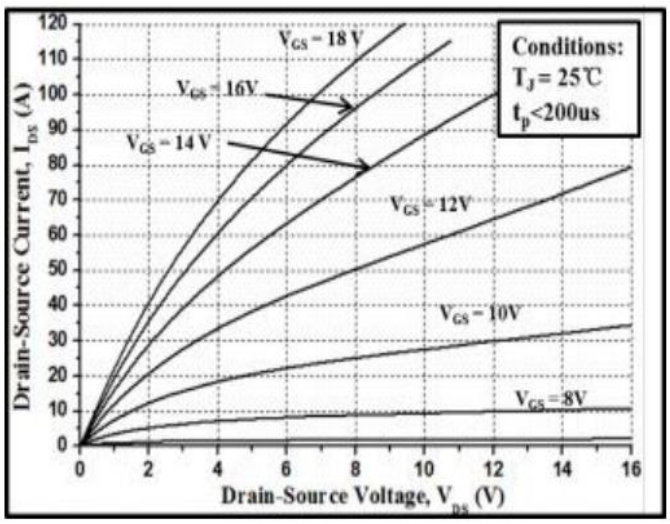


Figure 2. Output Characteristics T_J = 25℃

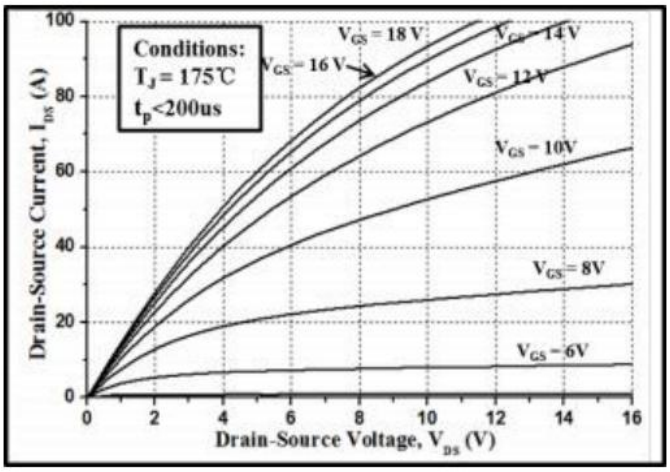


Figure 3. Output Characteristics T_J = 175℃

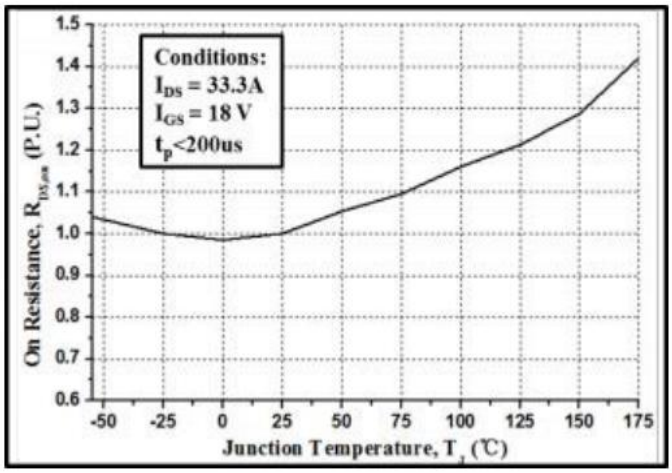


Figure 4. Normalized On-Resistance vs. Temperature

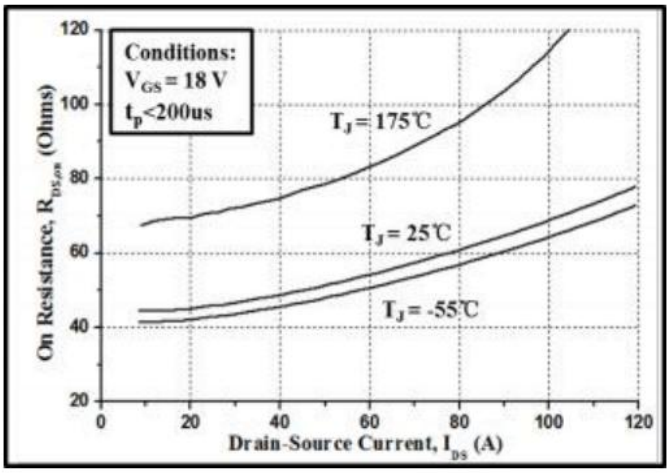


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

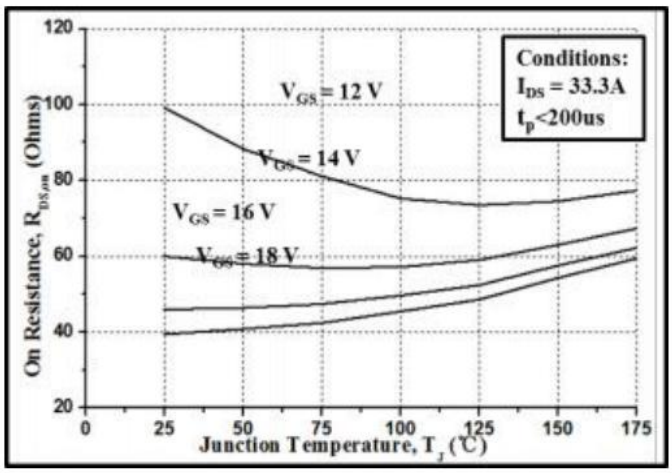


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

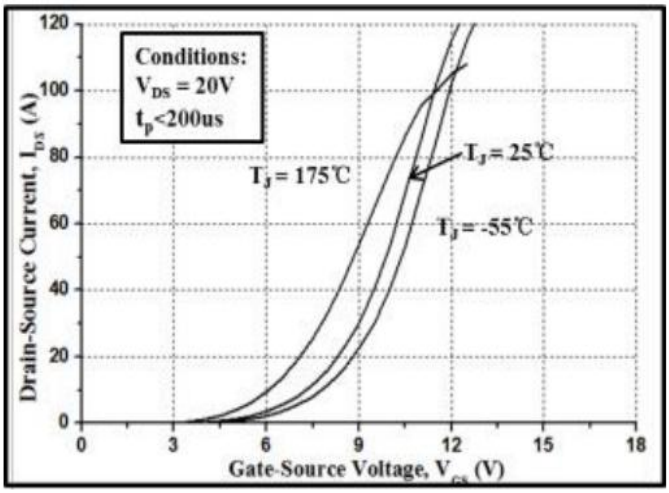


Figure 7. Transfer Characteristic for Various Junction Temperatures

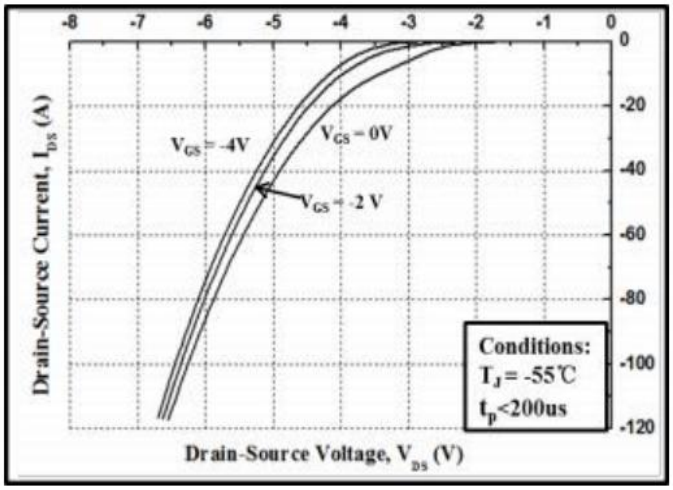


Figure 8. Body Diode Characteristic at -55℃

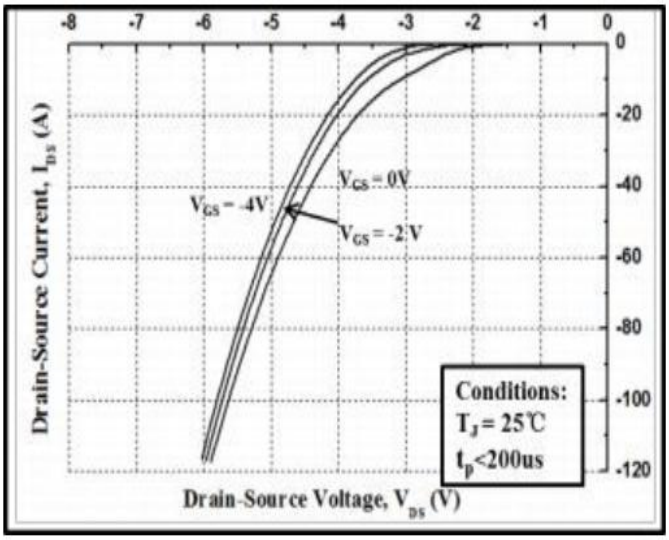


Figure 9. Body Diode Characteristic at 25℃

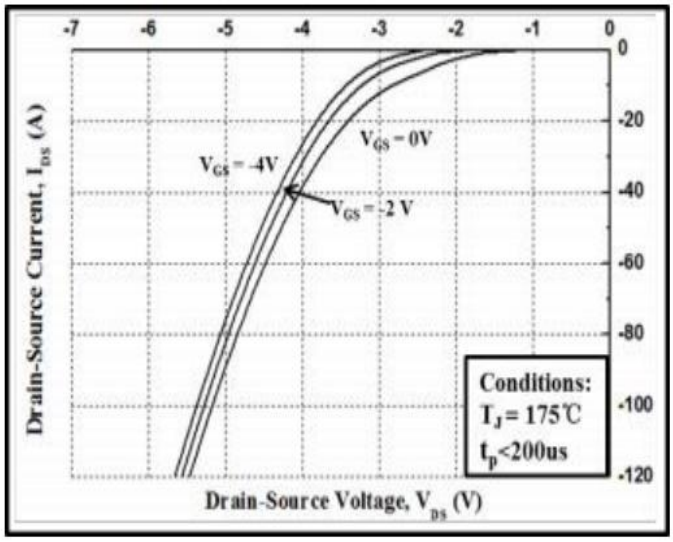


Figure 10. Body Diode Characteristic at 175℃

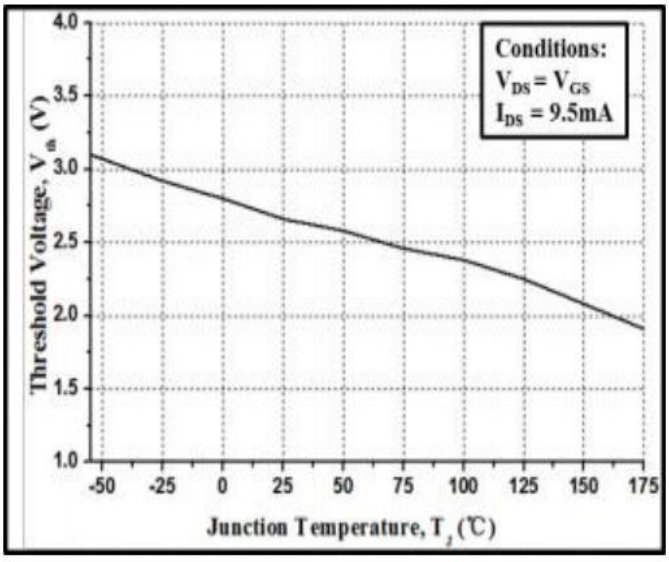


Figure 11. Threshold Voltage vs. Temperature

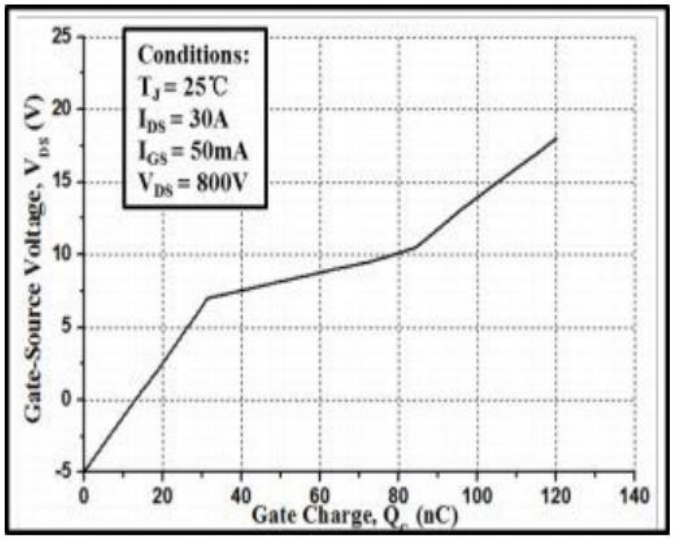


Figure 12. Gate Charge Characteristics

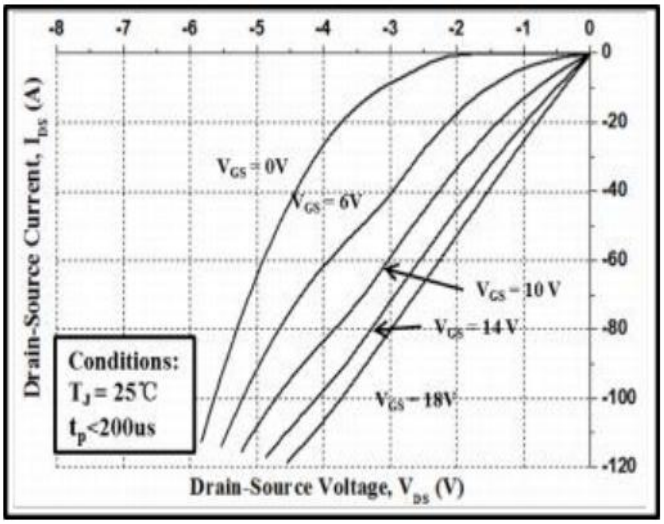


Figure 13. 3rd Quadrant Characteristic at 25℃

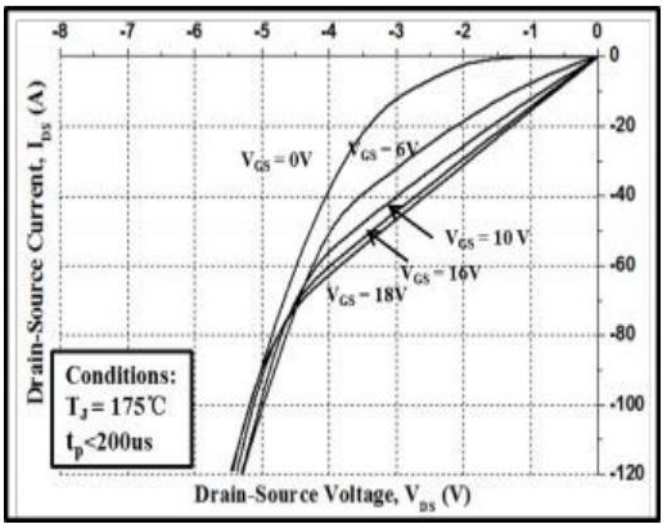


Figure 14. 3rd Quadrant Characteristic at 175℃

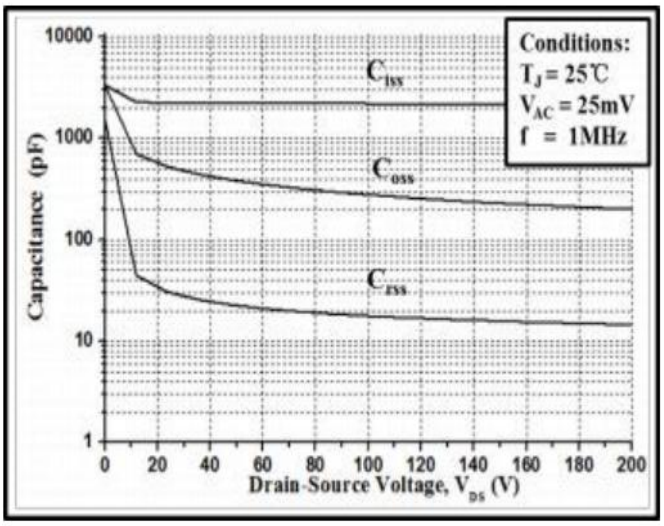


Figure 15. Capacitances vs. Drain-Source Voltage (0 - 200V)

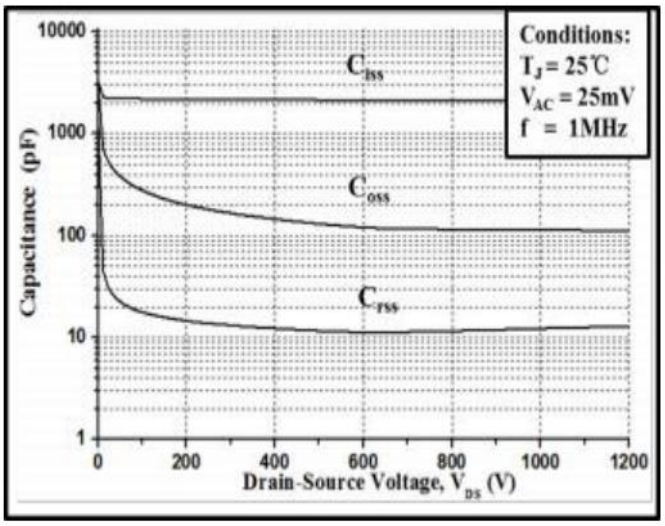
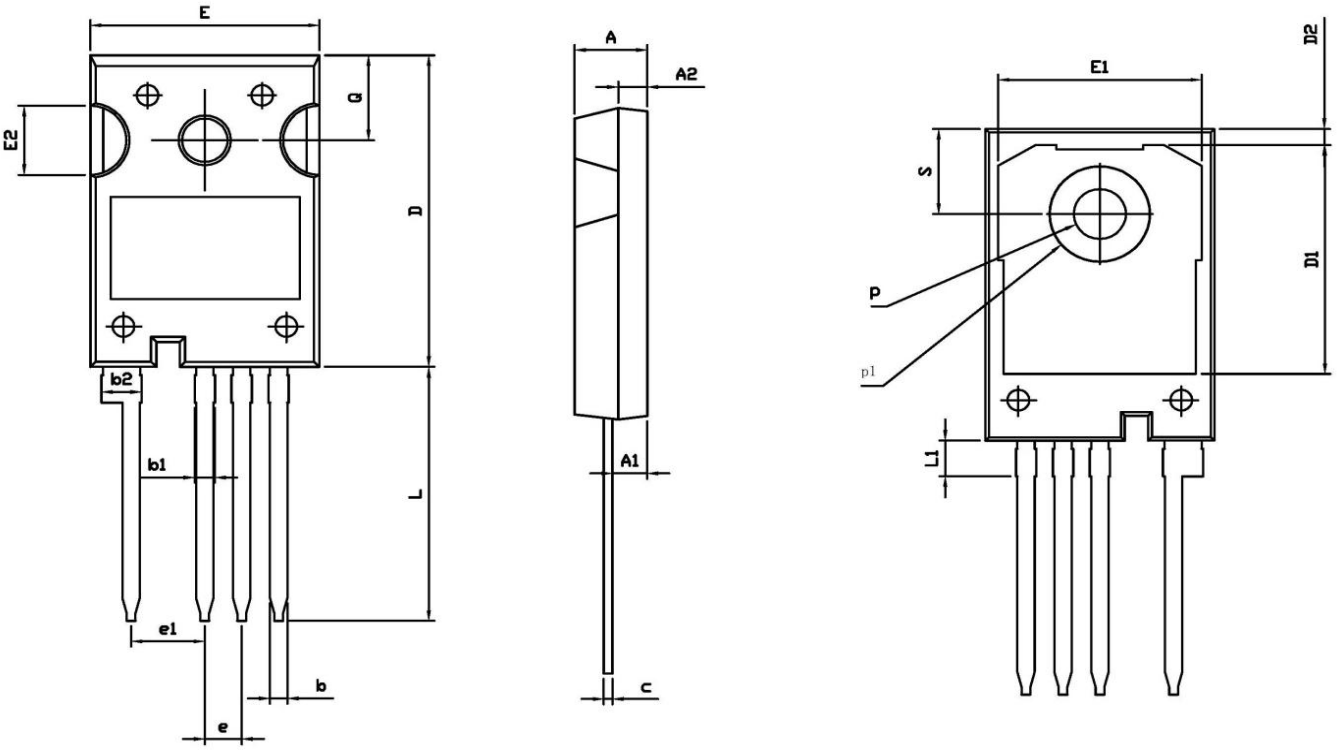
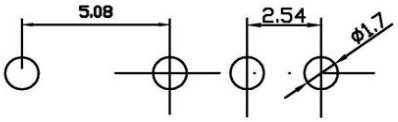


Figure 16. Capacitances vs. Drain-Source Voltage (0 - 1200V)

Package outline drawing(TO-247-4 Unit: mm)



RECOMMENDED LAND PATTERN



UNIT: mm

	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.25	2.40	2.45
A2	1.85	2.00	2.15
b	1.05	1.20	1.35
b1	1.00	1.30	1.60
b2	2.35	2.65	2.95
c	0.50	0.60	0.70
D	22.34	22.54	22.74
D1	16.00	16.50	17.00
D2	0.97	1.17	1.37
e	2.34	2.54	2.74
e1	4.88	5.08	5.28
E	15.60	15.80	16.00
E1	13.50	14.00	14.50
E2	4.80	5.00	5.20
L	18.08	18.38	18.68
L1	2.38	2.58	2.78
p	3.50	3.60	3.70
p1	6.60	6.80	7.00
Q	6.00	6.15	6.30
S	6.00	6.15	6.30

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